

COURSE CODE	COURSE NAME	L-T-P-C	YEAR OF INTRODUCTION
EC461	MICROWAVE DEVICES AND CIRCUITS	3-0-0-3	2016
Prerequisite: EC403 Microwave & Radar Engineering			
Course objectives: <ul style="list-style-type: none">To study microwave semiconductor devices & applications.To study microwave sources and amplifiers.To analyse microwave networks.To introduce microwave integrated circuits.			
Syllabus: Limitation of conventional solid state devices at Microwave, Gunn – effect diodes, Microwave generation and amplification, IMPATT and TRAPATT diodes, Bipolar transistors, MESFET, Microwave amplifiers and oscillators, Microwave Network Analysis, Signal flow graphs, Microwave filters, Filter design by image parameter method, Filter transformation and implementation, Introduction to MICs, Distributed and lumped elements of integrated circuits, Diode control devices			
Expected outcome: The Students will be able to understand with active & passive microwave devices & components used in microwave communication systems and analyse microwave networks.			
Text Books: <ul style="list-style-type: none">1. David M. Pozar, Microwave Engineering, 4/e, Wiley India, 20122. Robert E. Collin, Foundation of Microwave Engineering, 2/e, Wiley India, 2012.3. Samuel Y. Liao, Microwave Devices and Circuits, 3/e, Pearson Education, 2003.			
References: <ul style="list-style-type: none">1. Bharathi Bhat and Shibani K. Koul: Stripline-like Transmission Lines for MIC, New Age International (P) Ltd, 1989.2. I Kneppo, J. Fabian, et al., Microwave Integrated Circuits, BSP, India, 2006.3. Leo Maloratsky, Passive RF and Microwave Integrated Circuits, Elsevier, 2006.			
Course Plan			
Module	Course contents	Hours	End Sem. Exam Marks
I	Introduction, Characteristic, features of microwaves, Limitation of conventional solid state devices at Microwave.	1	15%
	Gunn – effect diodes – Gunn effect, Ridley – Watkins-Hilsum theory, Modes of operation, Limited space – Charge accumulation (LSA) mode of Gunn diode.	2	
	Microwave generation and amplification. Structure, Operation, Power output and efficiency of IMPATT and TRAPATT diodes	2	
II	Bipolar transistors – biasing, FET – biasing, MESFET – Structure, Operation.	4	15%
	Microwave amplifiers and oscillators – Amplifiers – Gain and stability, Single stage transistor amplifier design.	4	
	Oscillator design – One port negative resistance oscillators.	2	
FIRST INTERNAL EXAM			

III	Microwave Network Analysis – Equivalent voltages and currents, Impedance and Admittance matrices, Scattering matrix, The transmission matrix.	3	15%
	Signal flow graphs. Impedance matching and tuning – Matching with lumped elements, Single stub tuning, Double stub tuning. Quarter wave transformer, Theory of small reflections.	4	
IV	Microwave filters – Periodic structures – Analysis of infinite periodic structures and terminated periodic structures, Filter design by image parameter method – Constant k, m-derived and composite. Filter design by insertion loss method. Filter transformation and implementation.	7	15%
SECOND INTERNAL EXAM			
V	Introduction to MICSS:-Technology of hybrid MICs, monolithic MICs. Comparison of both MICs.	4	20%
	Planar transmission lines such as stripline, microstrip line, and slotline.	3	
VI	Distributed and lumped elements of integrated circuits - capacitors, inductors, resistors, terminations, attenuators, resonators and discontinuities.	5	20%
	Diode control devices – switches, attenuators, limiters. Diode phase shifter. Circulators and isolators.	2	
END SEMESTER EXAM			

Question Paper Pattern

The question paper shall consist of three parts. Part A covers modules I and II, Part B covers modules III and IV, and Part C covers modules V and VI. Each part has three questions uniformly covering the two modules and each question can have maximum four subdivisions. In each part, any two questions are to be answered. Mark patterns are as per the syllabus with 70% for theory and 30% for logical/numerical problems, derivation and proof.